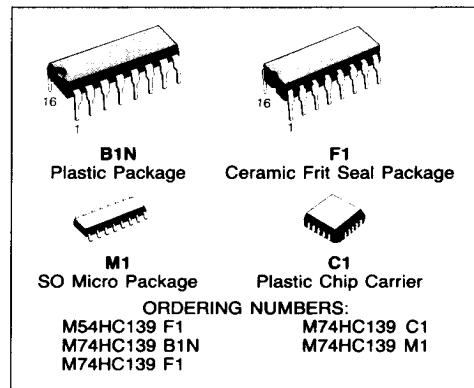


## DUAL 2-TO-4 LINE DECODER/DEMULTIPLEXER

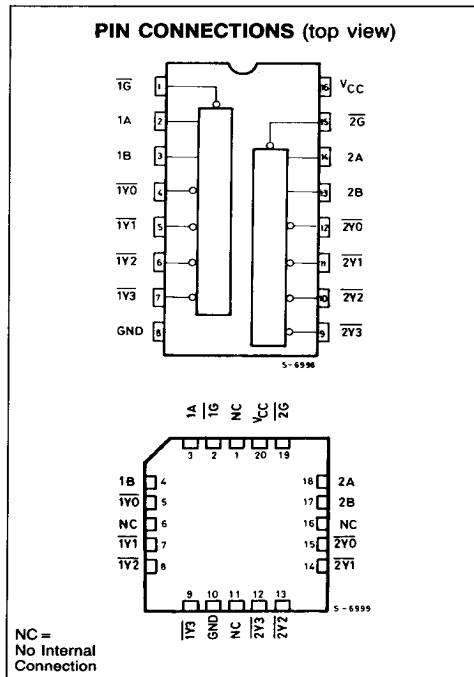
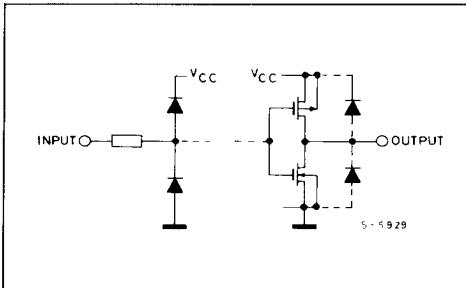
- HIGH SPEED  
 $t_{PD} = 16 \text{ ns (TYP.)}$  at  $V_{CC} = 5V$
- LOW POWER DISSIPATION  
 $I_{CC} = 4 \mu\text{A}$  (MAX.) at  $T_A = 25^\circ\text{C}$
- HIGH NOISE IMMUNITY  
 $V_{NIH} = V_{NIL} = 28\%$   $V_{CC}$  (MIN.)
- OUTPUT DRIVE CAPABILITY  
 10 LSTTL LOADS
- SYMMETRICAL OUTPUT IMPEDANCE  
 $|I_{OH}| = |I_{OL}| = 4 \text{ mA (MIN.)}$
- BALANCED PROPAGATION DELAYS  
 $t_{PLH} = t_{PHL}$
- WIDE OPERATING VOLTAGE RANGE  
 $V_{CC}$  (OPR) = 2V to 6V
- PIN AND FUNCTION COMPATIBLE  
 WITH 54/74LS139



### DESCRIPTION

The M54/74HC139 is a high speed CMOS DUAL TWO LINE TO FOUR LINE DECODER/DEMUL-TIPLEXER fabricated in silicon gate C<sup>2</sup>MOS technology. It has the same high speed performance of LSTTL combined with true CMOS low power consumption. The active low enable input can be used for gating or as a data input for demultiplexing applications. While the enable input is held high, all four outputs are high independently of the other inputs. All inputs are equipped with protection circuits against static discharge and transient excess voltage.

### INPUT AND OUTPUT EQUIVALENT CIRCUIT

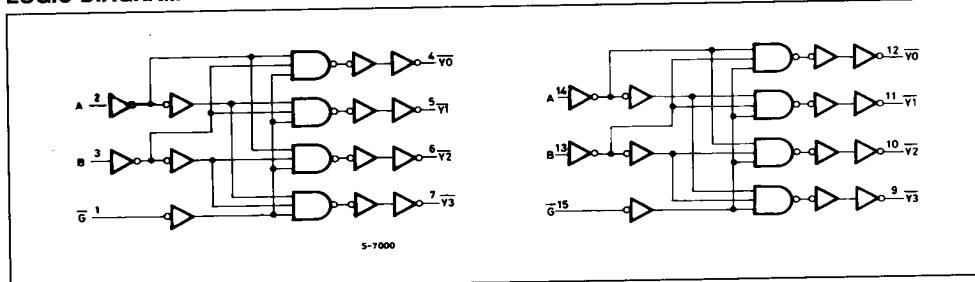


## TRUTH TABLE

INPUTS			OUTPUTS				SELECTED OUTPUT
ENABLE	SELECT		$Y_0$	$\bar{Y}_1$	$\bar{Y}_2$	$\bar{Y}_3$	
G	B	A					
H	X	X	H	H	H	H	NONE
L	L	L	L	H	H	H	$\bar{Y}_0$
L	L	H	H	L	H	H	$\bar{Y}_1$
L	H	L	H	H	L	H	$\bar{Y}_2$
L	H	H	H	H	H	L	$\bar{Y}_3$

X: DON'T CARE

## LOGIC DIAGRAM



## ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
$V_{CC}$	Supply Voltage	- 0.5 to 7	V
$V_I$	DC Input Voltage	- 0.5 to $V_{CC} + 0.5$	V
$V_O$	DC Output Voltage	- 0.5 to $V_{CC} + 0.5$	V
$I_{IK}$	DC Input Diode Current	$\pm 20$	mA
$I_{OK}$	DC Output Diode Current	$\pm 20$	mA
$I_O$	DC Output Source Sink Current Per Output Pin	$\pm 25$	mA
$I_{CC}$ or $I_{GND}$	DC $V_{CC}$ or Ground Current	$\pm 50$	mA
$P_D$	Power Dissipation	500 (*)	mW
$T_{stg}$	Storage Temperature	- 65 to 150	°C

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these conditions is not implied.

(\*) 500 mW:  $\equiv 65^\circ\text{C}$  derate to 300 mW by 10 mW/ $^\circ\text{C}$ :  $65^\circ\text{C}$  to  $85^\circ\text{C}$

## RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Value			Unit
$V_{CC}$	Supply Voltage	2 to 6			V
$V_I$	Input Voltage	0 to $V_{CC}$			V
$V_O$	Output Voltage	0 to $V_{CC}$			V
$T_A$	Operating Temperature 74HC Series 54HC Series	-40 to 85 -55 to 125			°C
$t_r, t_f$	Input Rise and Fall Time	$V_{CC}$	2 V 4.5V 6 V	0 to 1000 0 to 500 0 to 400	ns

## DC SPECIFICATIONS

Symbol	Parameter	$V_{CC}$	Test Condition	$T_A = 25^\circ C$ 54HC and 74HC			-40 to 85°C 74HC		-55 to 125°C 54HC		Unit
				Min.	Typ.	Max.	Min.	Max.	Min.	Max.	
$V_{IH}$	High Level Input Voltage	2.0 4.5 6.0		1.5 3.15 4.2	— — —	— — —	1.5 3.15 4.2	— — —	1.5 3.15 4.2	— — —	V
$V_{IL}$	Low Level Input Voltage	2.0 4.5 6.0		— — —	— — —	0.5 1.35 1.8	— — —	0.5 1.35 1.8	— — —	0.5 1.35 1.8	V
$V_{OH}$	High Level Output Voltage	2.0 4.5 6.0 4.5 6.0	$V_I$	$I_O$	1.9 4.4 5.9	2.0 4.5 6.0	— — —	1.9 4.4 5.9	— — —	1.9 4.4 5.9	— — —
			$V_{IH}$ or $V_{IL}$	-20 $\mu A$ -4.0 mA -5.2 mA	4.18 5.68	4.31 5.8	— —	4.13 5.63	— —	4.10 5.60	— —
$V_{OL}$	Low Level Output Voltage	2.0 4.5 6.0 4.5 6.0	$V_I$ $V_{IH}$ or $V_{IL}$	20 $\mu A$ 4.0 mA 5.2 mA	— — —	0 0.17 0.18	0.1 0.26 0.26	— — —	0.1 0.33 0.33	— — —	0.1 0.1 0.1
					— —	0 0.17 0.18	0.1 0.26 0.26	— — —	0.1 0.33 0.33	— — —	0.1 0.40 0.40
$I_I$	Input Leakage Current	6.0	$V_I = V_{CC}$ or GND	—	—	$\pm 0.1$	—	$\pm 1$	—	$\pm 1$	$\mu A$
$I_{CC}$	Quiescent Supply Current	6.0	$V_I = V_{CC}$ or GND	—	—	4	—	40	—	80	$\mu A$

AC ELECTRICAL CHARACTERISTICS ( $V_{CC} = 5V$ ,  $T_A = 25^\circ C$ ,  $C_L = 15pF$ , Input  $t_r = t_f = 6ns$ )

Symbol	Parameter	54HC and 74HC			Unit
		Min.	Typ.	Max.	
$t_{TLH}$ $t_{THL}$	Output Transition Time		4	8	ns
$t_{PLH}$ $t_{PHL}$	Propagation Delay Time		16	26	ns
$t_{PLH}$ $t_{PHL}$	Propagation Delay Time (G-Y)		14	23	ns

AC ELECTRICAL CHARACTERISTICS ( $C_L = 50\text{pF}$ , Input  $t_r = t_f = 6\text{ns}$ )

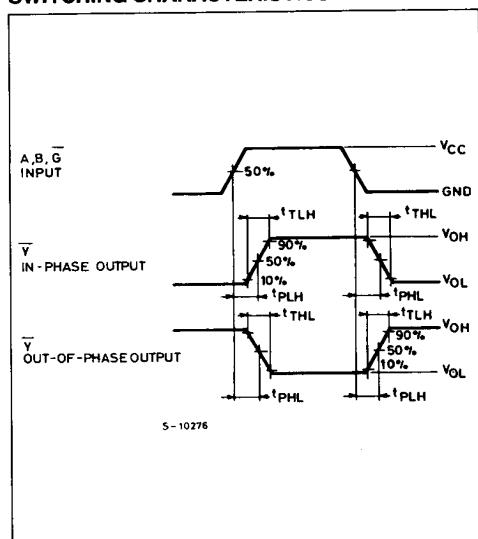
Symbol	Parameter	V <sub>CC</sub>	Test Condition	T <sub>A</sub> = 25°C 54HC and 74HC			- 40 to 85°C 74HC		- 55 to 125°C 54HC	
				Min.	Typ.	Max.	Min.	Max.	Min.	Max.
t <sub>TLH</sub> T <sub>THL</sub>	Output Transition Time	2.0 4.5 6.0		—	30	75	—	95	—	110
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay Time A, B-Y	2.0 4.5 6.0		—	8	15	—	19	—	22
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay Time G-Y	2.0 4.5 6.0		—	7	13	—	16	—	19
t <sub>PLH</sub> t <sub>PHL</sub>				—	76	150	—	190	—	225
t <sub>PLH</sub> t <sub>PHL</sub>				—	19	30	—	38	—	45
t <sub>PLH</sub> t <sub>PHL</sub>				—	17	26	—	33	—	38
C <sub>IN</sub>	Input Capacitance			—	68	135	—	170	—	205
C <sub>PD</sub> (*)	Power Dissipation Capacitance			—	15	23	—	29	—	41
				—	49	—	—	—	—	35
				—	5	10	—	10	—	pF
				—	—	—	—	—	—	pF

Note (\*) C<sub>PD</sub> is defined as the value the IC's of internal equivalent capacitance which is calculated from the operating current consumption without load. (Refer to Test Circuit)

Average operating current can be obtained by the following equation.

$$I_{CC(\text{opr})} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$$

## SWITCHING CHARACTERISTICS TEST CIRCUIT

TEST CIRCUIT I<sub>CC</sub> (Opr.)